

<b>Notice of References Cited</b>	Application/Control No. 10/016,633	Applicant(s)/Patent Under Reexamination PEITER ET AL.	
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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,214,703	04-2001	Chen et al.	438/462
	B	US-6,156,676	12-2000	Sato et al.	438/798
	C	US-5,597,590	01-1997	Tanimoto et al.	425/174.4
	D	US-4,044,222	08-1977	Kestenbaum, Ami	219/121.71
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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